

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination AL-KOFAHI ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Uyen T. Le	2171	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,383,120	01-1995	Zernik, Uri	704/10
	B	US-6,502,081	12-2002	Wiltshire et al.	706/12
*	C	US-2004/0039786	02-2004	Horvitz et al.	709/207
*	D	US-6,038,527	03-2000	Renz, Ingrid	704/9
*	E	US-5,918,240	06-1999	Kupiec et al.	715/531
*	F	US-5,778,397	07-1998	Kupiec et al.	715/500
*	G	US-6,651,058	11-2003	Sundaresan et al.	707/6
*	H	US-2003/0004716	01-2003	Haigh et al.	704/238
*	I	US-6,760,701	07-2004	Sharma et al.	704/249
*	J	US-6,539,352	03-2003	Sharma et al.	704/249
*	K	US-2002/0099730	07-2002	Brown et al.	707/500
*	L	US-6,751,600	06-2004	Wolin, Ben	706/12
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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